Unravelling a Zigzag Pathway for Hot Carrier Collection with Graphene Electrode

Jin Zhang, Hao Hong, Jincan Zhang, Chunchun Wu, Hailin Peng, Kailui Liu, and Sheng Meng*

ABSTRACT: The capture of photoexcited deep-band hot carriers, excited by photons with energies far above the bandgap, is of significant importance for photovoltaic and photoelectronic applications because it is directly related to the quantum efficiency of photon-to-electron conversion. By employing time-resolved photoluminescence and state-of-the-art time-domain density functional theory, we reveal that photoexcited hot carriers in organic–inorganic hybrid perovskites prefer a zigzag interfacial charge-transfer pathway, i.e., the hot carriers transfer back and forth between CH3NH3PbI3 and graphene electrode, before they reach a charge-separated state. Driven by quantum coherence and interlayer vibrational modes, this pathway at the semiconductor–graphene interface takes about 400 fs, much faster than the relaxation process within CH3NH3PbI3 (several picoseconds). Our work provides new insight into the fundamental understanding and precise manipulation of hot carrier dynamics at the complex interfaces, paving the way for highly efficient photovoltaic and photoelectric device optimization.

In conventional solar cells, hot charge carriers are generated by absorbing photons with energies larger than the bandgaps, which is generally followed by a quick cooling process; that is, the hot electrons relax to the band edges of semiconductors.1–3 If the hot carriers can be captured within a time significantly shorter than the competing energy relaxation and loss processes, light-to-electricity conversion efficiency could be improved effectively. van der Waals (vdW) heterostructures provide a potential platform for investigating new physics and optoelectrical applications in hot carrier solar cells.4–10 To achieve desirable performance in hot carrier devices based on vdW heterostructures, it is of central importance to understand and manipulate photoexcited hot carrier dynamics on an ultrafast time scale at the interfaces.11–14

Benefiting from the excellent optical properties, such as near-infrared to visible tunable bandgap, ultrahigh absorption, near-unity photoluminescence (PL) quantum yield, and nanosecond-scale long-lived photocarrier lifetime, organic–inorganic hybrid perovskites, e.g., CH3NH3PbI3 (termed MAPbI3 hereafter), have emerged as ideal photoactive materials and been successfully used in light detection and emitters recently.15–25 With two-dimensional (2D) graphene covered as an electrode, the perovskite–graphene heterostructures have gained substantial interest.26–29 Several experimental works have reported interfacial carrier dynamics and high photore sponsivity on perovskite–graphene heterostructures.27–30 Lee and coauthors demonstrated an intriguing photodetector consisting of MAPbI3 and graphene, achieving a relatively high photore sponsivity and an effective quantum efficiency (5 × 105 % at an illumination power of 1 μW).26

Recently, Hong et al. reported that graphene is an excellent carrier acceptor which extracts photoexcited hot carriers of MAPbI3 crystal with interfacial deep-band charge transfer in less than 50 fs, significantly faster than the hot carrier relaxation or cooling process.27 They focused on the ultrafast broadband charge collection at the clean graphene/organic–inorganic halide perovskite interfaces in an ultrashort time of ~100 fs, with a high collection efficiency close to 99%. However, a comprehensive understanding of the dynamic process of photoexcited hot carriers at the semiconductor–graphene interfaces is still rare and in its early stages.

In this Letter, we utilize tunable two-color pump–probe spectroscopy, time-resolved PL spectroscopy, and the state-of-the-art time-domain density functional theory (DFT) to study the interlayer charge dynamics in model CH3NH3PbI3/graphene (i.e., MAPbI3/graphene) heterostructure. Our results reveal that the ultrafast interlayer charge transfer in the heterostructure takes place on an order of ~400 fs, in good agreement with experimental observations. Surprisingly, we find that photoexcited hot carriers in organic–inorganic hybrid perovskites prefer to undergo a zigzag pathway, i.e., the hot electrons travel back and forth between MAPbI3 and graphene. This work not only provides a new and complete physical...
picture into the hot carrier collection in heterostructures with graphene electrode on the atomic level but also sheds light on optimizing their performance toward future applications in high-speed photodetection and highly efficient light-harvesting materials.

In our experiments, chemical vapor deposition (CVD) grown graphene monolayer was cleanly transferred on a transmission electron microscopy (TEM) grid without polymer assistance (Figure S1 in the Supporting Information). Then the clean interface of MAPbI3/graphene was fabricated by directly growing single-crystal MAPbI3 crystals on suspended graphene, as shown in Figure 1a. MAPbI3 crystal with a uniform thickness resides on the suspended graphene. The thickness of the perovskite is roughly determined to be 5–10 nm. Therefore, we can safely consider only the interfacial coupling and an e−ff transfer to graphene because of the band alignment. Pathway 2 is illustrated in Figure 2b, where the photoexcited hot electron (e−ff) in MAPbI3 first relaxes to the band edge of MAPbI3 and then di−ffuses to graphene. (b) Pathway 2: photoexcited hot electron in MAPbI3 first transfers to graphene and then relaxes among graphene. (c) Pathway 3: photoexcited hot electron in MAPbI3 first transfers to graphene across a zigzag pathway at semiconductor–graphene interfaces. I, II, and III indicate the separate steps of the pathway. Here, we consider the dynamics of photoexcited hot electrons while we observe similar results for hot holes (see the Supporting Information).

Figure 1. Experimental samples and pump−probe measurements of MAPbI3/graphene heterostructure. (a) Transmission electron microscopy (TEM) image of the suspended MAPbI3/graphene. (b) Representative aberration-corrected TEM images of the lattice structure of MAPbI3. Typical lattice parameters are illustrated in the figure. The scale bar is 2 nm. (c) Photoluminescence (PL) spectra of MAPbI3 with (MAPbI3/Gr) and without graphene (MAPbI3). (d) Time-resolved PL of pristine MAPbI3 and MAPbI3/Gr. With graphene underneath, the carrier lifetime of MAPbI3 reduces dramatically from 25 to 1.3 ns. (e and f) The rise-up transient absorption spectrum of pristine MAPbI3 (e) and graphene (f) under probe wavelength at 750 nm.

In our time-resolved PL experiments, pristine MAPbI3 has a lifetime of ∼25 ns, while the lifetime of the MAPbI3/graphene heterostructure is reduced significantly to ∼1.3 ns. The carrier collection efficiency at the interface can be estimated from either the PL quench (ηPL = 1 − τwGr/τw/oGr = 95%) or the lifetime decreases (τw/oGr = 99%, where τw/oGr and τwGr indicate lifetimes of MAPbI3/graphene and pristine MAPbI3, respectively). These two different methods yield two different values, with the former one a little larger than the latter one. For the time-resolved PL experiment, the lifetime of cooling carriers at the band edge is measured. While it is a little complicated for the case of PL experiments, where deep-band carriers are excited and may directly transfer to graphene right after high-energy photons excitation. After high-energy excitation in perovskite, the carrier relaxation or cooling process inside the perovskite is very slow, with a typical time scale of ∼1 ps, as shown in the rise-up curve of Figure 1e (transient absorption signal with pump and probe wavelength at 400 and 750 nm, respectively), mainly because of phonon bottleneck effects.

By contrast, hot carrier relaxation in graphene is relatively faster, with rise-up time of ∼0.4 ps (transient absorption signal with the same conditions as MAPbI3) (Figure 1f). The transient absorption scales linearly as a function of pump fluence, implying no nonlinear effects are involved in measurement (Figure S2). Therefore, the dynamic process of the photoexcited hot carriers at the semiconductor–graphene interfaces may be much more complicated and deserves a thorough time-domain atomistic description.

In Figure 2, we demonstrate three potential pathways involved in the photoinduced hot electron dynamics at the MAPbI3/graphene heterojunction. In the beginning, optical excitation with a high-energy photon (hv > bandgap of MAPbI3) generates an electron (e−ff) and hole (h+ff) pair. Then, the hot carrier diffuses to graphene on account of the semiconductor–semimetal contacts. For pathway 1 (Figure 2a), the excited hot electron at MAPbI3 first relaxes to the conduction band minimum (CBM) or the band edge of MAPbI3 and then diffuses to graphene because of the band alignment. Pathway 2 is illustrated in Figure 2b, where the photoexcited hot carriers first transfer to the lowest-energy state of graphene and then relax to the Dirac point. Beyond them, strong interfacial interactions between MAPbI3 and graphene may result in an alternative mechanism (pathway 3 in Figure 2c), where the hot electrons travel back and forth between the semiconductor and graphene in a zigzag pathway. The dominant pathway is determined by comparable time...
scales of interlayer charge transfer and intralayer hot carrier relaxation within the two individual components.

Considering our experimental observations as well as results from previous work, we choose the vertical heterostructure of MAPbI3 and graphene as a model to exploit the interfacial electronic properties and photoexcitation induced carrier dynamics in the semiconductor-semimetal interfaces.

More information comes from the projected density of states (PDOS) of the heterostructure. The bandgap of MAPbI3 in the heterostructure calculated with the Perdew–Burke–Ernzerhof (PBE) functional is about 2.3 eV, and graphene is semimetallic with a zero bandgap (Figure S3). The CBM and valence band maximum (VBM) are both contributed mainly by electronic orbitals from MAPbI3, reflecting a typical semiconductor-semimetal contact. One of the crucial parameters for charge diffusion at the interface is the band offsets at both CBM and VBM states. To validate our results, we compare the PDOS at the PBE level with that based on the HSE06 functional (Figure S3). It is observed that the PBE functional is accurate enough to describe the spatial distribution of electronic states and the state couplings at MAPbI3/graphene interfaces.

To investigate hot carrier dynamics, we performed nonadiabatic analysis incorporating all orbitals with energies higher than the Fermi level of the heterostructure. Here, two typical hot electron states are selected: 3.2 and 2.9 eV above the Fermi level, respectively, and their dynamics are closely tracked. The hot electron states are selected according to the pump energy at 410 nm used in the pump–probe experiments discussed above. The spatial distributions of the CBM state in MAPbI3 and the low-energy state above the Fermi level of graphene are also presented in Figure S5. The delocalization of the CBM state in MAPbI3 is an indication of a relatively strong interfacial coupling.

To gain quantitative information, we integrate carrier populations on graphene orbitals at different times upon photoexcitation. The evolution of the localization is shown in Figure 3, where the population represents the fraction of the photoexcited charge density on the graphene sheet. At t = 0 fs, the two photoexcited states are mostly distributed on MAPbI3, with 10% (for the state of 3.2 eV) and 20% (for the state of 2.9 eV) of the excited hot electrons diffuse to graphene in an ultrafast time scale (<20 fs for both states, Figure 3a). The population on graphene increases from 10% to 34% for the first charge diffusion process. In the following, the hot electron diffuses back to MAPbI3 and the population on graphene decreases to 23% at 50 fs. This process is not surprising because similar processes were observed in which a photoexcited hot carrier in graphene can inject into semiconductors (i.e., WS2) in about 25 fs, accompanied by a quantum yield as high as ∼50%. Afterward, the hot electrons diffuse from MAPbI3 to graphene with a large percentage (∼86%) within 600 fs. Simultaneously, the energy of the state decreases continuously from 2.9 to 1.0 eV upon photoexcitation (Figure 3b). Consequently, the time scale of the whole process is 400 fs with exponential fitting. The energy relaxation converges around 1 eV above the Fermi level (Figure 3b), because some states above the Fermi level of graphene are not included in the simulation because of the limit of the supercell.

Figure 3. Hot carrier dynamics at MAPbI3–graphene interfaces. (a) Population at MAPbI3 of excited hot electron with initial photoexcited energies of 3.2 and 2.9 eV above the Fermi energy as a function of time upon optical excitation. For clarity, the inset shows the zoomed-in region from 0 to 100 fs. (b) Corresponding energy evolution of excited hot electrons. The inset cartoon exhibits the zigzag pathway in real space. Pathway 3 can be roughly divided into three substeps. (c) Evolution of the population of the hot electron from MAPbI3 to graphene (step I). (d) Evolution of the population of the transferred hot electron state on graphene diffuses to MAPbI3 on an ultrafast time scale of 30 fs (step II). (e) The excited electron at CBM transfers to graphene in 92 fs (step III). The time evolution data are fitted with exponential functions.
By contrast, the charge population on graphene increases significantly in 23 fs (Figure 3a) for the excited state with the energy of 3.2 eV above the Fermi level. Then, this value drops to 30% at t = 75 fs. The total time scale of the photoexcited process is observed to be about 400 fs, accompanied by the energy decreasing continuously. These findings reveal there exists a new robust relaxation process (pathway 3) on a time scale of ∼400 fs, validating the experimentally observed ultrafast broadband charge transfer from MAPbI3 to graphene.27 Previous experiments have revealed that hot carrier relaxation in graphene takes place within ∼1 ps.27 The result agrees well with our TDDFT calculations (the relaxation time is about 0.8 ps), as shown in Figure S6.

To have a clear understanding of the mechanism of the entangled processes, we separate the distinct processes by involving only relative states in the vicinity of the excited electron state. For step I (Figure 3c), the time scale of charge diffusion is about 23 fs from MAPbI3 to graphene, in good agreement with experimental observation (<50 fs). Then in the following 30 fs, the electron-transfer process from graphene back to MAPbI3 takes place (step II, as shown in Figure 3d).

On the other hand, there is an alternative cooling routine for the hot carriers: rapid electron–hole annihilation inside the semimetallic graphene with the assistance of effective electron–phonon and electron–electron scattering. This energy loss competes with charge separation and the dominant one determined by relative time scales. It is obtained that the relaxation time scale is ∼1 ps fs for the hot electron with the energy of ∼3.0 eV above the Fermi level in graphene, significantly slower than the interfacial charge-transfer process (30 fs). The lifetime is on the same order of magnitude with previous experimental studies (∼50 fs),17 accounting for the strong interfacial interactions between MAPbI3 and graphene and the assistance of interlayer phonon vibrations. For MAPbI3, it is shown that the cooling process of hot carriers apparently takes a longer time (∼50 ps). Thus, the energy relaxation within both graphene and MAPbI3 is much slower than the interface-assisted carrier dynamics, facilitating the novel pathway where hot electrons in the heterostructure would travel back and forth.

In order to accurately account for the band-edge carrier transfer, Figure 3e illustrates that the excited electrons at the CBM of MAPbI3 further diffuse to graphene in 92 fs, in excellent accordance with the previous experimental result (110 fs).27 These findings further rationalize the distinct charge dynamics for the band-edge electron (with the pump energy at 1.5 eV, 820 nm) and hot electron (pump energy of ∼3.0 eV, 410 nm) from MAPbI3 to graphene using the PL excitation spectrum in experiments. Therefore, the results validate the novel and robust pathway 3, instead of the conventional decay pathways 1 and 2 at the vdW interfaces.

To further understand the peculiar pathway for photoexcited hot electron dynamics, more information coming from the effect of decoherence and phonons is analyzed in Figure 4a. Fourier transformation of the energy difference along the molecular dynamics permits a quantitative analysis of the crucial phonon vibrations mediated in the process (Figure 4b). We obtain that the Pb–I bond stretching mode (∼90 cm−1) and the liberation of the organic cations (CH3NH3+) at ∼120 cm−1 in perovskite–graphene heterostructure indeed plays a dominant role in ultrafast hot electron dynamics.27,46 In addition, the frequency around 1500 cm−1 is attributed to carbon–carbon stretching modes in graphene. Therefore, phonon modes in both MAPbI3 and graphene are involved in assisting the emergent zigzag-like hot electron-transfer route. This observation, together with strong coupling between MAPbI3 and graphene layers, elucidates the mechanism of the newly discovered hot–electron collection channel.

In addition to the zigzag pathway, the photoexcited hot carriers may experience even more complicated pathways (e.g., incorporating more states of graphene around the Fermi level and delicate interfacial charge-transfer processes). Thus, to fully understand the fate of photoexcited carriers, one should consider ultrafast intralayer/interlayer carrier scatterings, interfacial excitons, and charge-transfer processes at the semiconductor–graphene heterostructures. Besides, we also consider the dynamics of photoexcited hot electrons while we observe similar results for hot holes (Figure S7). The excitation light wavelength- and intensity-dependent TA measurement should be helpful for understanding the hot carrier-transfer process. We admit it is very difficult to directly prove the zigzag pathway for hot carrier collection by experiments. However, comprehensive comparison among different time scales for various processes validates the model shown in Figure 2. Beyond the graphene electrode, we envision the novel mechanism can be extended to other 2D metals, semimetals, surface states of topological insulators, and semiconductors if the interfacial interaction and atomic collective motions are strong enough to mediate the interlayer multiple charge transfer.
In summary, we demonstrate photoexcited hot carrier dynamics in heterostructures with graphene electrode using ultrafast transient absorption spectrum, time-resolves PL, and ab initio time-domain DFT simulations. We reveal that the strong interfacial interactions between MAPbI₃ and graphene result in a novel zigzag hot carrier cooling pathway, where the hot electron travels back and forth between semiconductors and graphene. Our calculations not only explain the experimentally observed ultrafast carrier dynamics upon photoexcitation at both band edges and deep bands but also experimentally observed ultrafast carrier dynamics upon photoexcitation at both band edges and deep bands but also present a new way to manipulate the hot carriers in semiconductor–graphene heterostructures in optoelectronic and photovoltaic applications. Therefore, improved device performance of hot carrier solar cells with graphene electrode may be achieved given that the photoexcited carriers in graphene can be extracted into electric circuits to minimize the loss in carrier conductors.

■ ASSOCIATED CONTENT

Supporting Information
The Supporting Information is available free of charge at https://pubs.acs.org/doi/10.1021/acs.jpcl.1c00347.

More details on photoinduced dynamics and methods (Figures S1–S7 and Note 1) (PDF)

■ AUTHOR INFORMATION

Corresponding Authors
Jin Zhang − Beijing National Laboratory for Condensed Matter Physics and Institute of Physics, Chinese Academy of Sciences, Beijing 100190, P.R. China; orcid.org/0000-0001-7830-3464; Email: jin.zhang@mpsd.mpg.de
Kaihui Liu − State Key Laboratory for Mesoscopic Physics, School of Physics, Peking University, Beijing 100871, P.R. China; Collaborative Innovation Center of Quantum Matter, Beijing 100190, P.R. China; orcid.org/0000-0002-8781-2495; Email: khlui@pku.edu.cn
Sheng Meng − Beijing National Laboratory for Condensed Matter Physics and Institute of Physics, Chinese Academy of Sciences, Beijing 100190, P.R. China; Collaborative Innovation Center of Quantum Matter, Beijing 100190, P.R. China; Key Laboratory of Material Physics, School of Physics, Zhengzhou University, Zhengzhou 450052, P.R. China; orcid.org/0000-0002-1553-1432; Email: smeng@iphy.ac.cn

Authors
Hao Hong − State Key Laboratory for Mesoscopic Physics, School of Physics, Peking University, Beijing 100871, P.R. China
Jincan Zhang − College of Chemistry and Molecular Engineering, Academy for Advanced Interdisciplinary Studies, Peking University, Beijing 100871, P.R. China
Chunchun Wu − State Key Laboratory for Mesoscopic Physics, School of Physics, Peking University, Beijing 100871, P.R. China
Hailin Peng − College of Chemistry and Molecular Engineering, Academy for Advanced Interdisciplinary Studies, Peking University, Beijing 100871, P.R. China; orcid.org/0000-0003-1569-0238

Complete contact information is available at: https://pubs.acs.org/10.1021/acs.jpcl.1c00347

Author Contributions
J.Z., H.H., and J.Z. contributed equally to this work

Notes
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